Thermo SCIENTIFIC

Invitation 5th XPS Workshop

Fundamentals and Applications of Surface Analysis

June 22nd-24th, 2016 Eggenstein-Leopoldshafen, Germany





Introduction

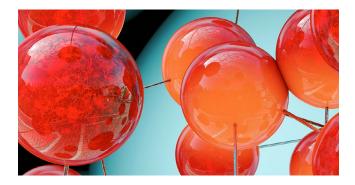
X-ray Photoelectron Spectroscopy (XPS) is a widely used analysis technique, which provides quantitative, chemical state information for surfaces and interfaces.

The XPS workshop addresses scientists, engineers, and technicians working in areas of materials science, who would like to get insight into the fundamentals of the technique and current applications and research areas.

Leading international scientists and industry experts will report on a range of important topics such as polymer surfaces and cluster depth profiling, biointerfaces, Li-ion batteries, catalysis, corrosion, and new instrument developments. Moreover, the importance of adjacent techniques to support XPS analysis will be introduced, such as Raman, REELS, and He ion microscopy.

Participants are invited to present their own research during the meeting as a flash presentation or as a poster during breaks in the programme.

See the technologies in action! There will also be an opportunity to see the Thermo Scientific[™] K-Alpha[™] XPS Spectrometer in action, and learn from the experts in a Thermo Scientific Avantage software training workshop.



Agenda

Wednesday, June 22 nd	
Moderation	Richard White
09:00	Registration, Welcome and Refreshments
09:30	Introduction Michael Bruns, IAM, Karlsruhe Institute of Technology, Germany; Richard White, Thermo Fisher Scientific, UK
09:45	XPS – From the basics to applications in materials sciences Richard White, Thermo Fisher Scientific, UK
10:30	Vision and highlights of KNMF Christian Kübel, INT, Karlsruhe Institute of Technology, Germany
10:45	Analytical challenges at the interface between soft matter materials and surface science Christopher Barner-Kowollik, Karlsruhe Institute of Technology, Germany
11:15	Assets of pARXPS and 300mm quasi-insitu analysis for advanced material studies in microelectronic Bernard Pelissier, LETI-CNRS, Grenoble, France
12:00	Lunch Break
13:00	Analysis and monitoring of SrTiO ₃ perovskite surfaces and LaAlO ₃ / SrTiO ₃ interfaces with cluster ion source coupled with electrical measurement Damien Aureau, Versailles University de Saint Quentin en Yvelines, France
13:45	In situ at NEXUS in the UK – In situ deposition, in situ multispectral imaging, in situ Raman Peter Cumpson, NEXUS, Newcastle University, UK
14:30	Coffee Break with Poster Session
15:15	Helium Ion Microscopy – A new tool for imaging at the nanoscale Ruth Schwaiger, IAM, Karlsruhe Institute of Technology, Germany
16:00	Flash Presentations Participants
17:00	End
19:00	Dinner sponsored by Thermo Fisher Scientific

Agenda

Thursday, June 23rd 09:00 Thermo Fisher Scientific XPS portfolio – Trends, new developments, outlook Richard White and Tim Nunney, Thermo Fisher Scientific. UK 09:45 **XPS-instrumentation for liquid-processed** samples - Concept and first experiences Gunther Wittstock, Universität Oldenburg, Germany 10:30 Coffee Break with Poster Session 11:00 Applied Surface Science – XPS projects at KNMF Michael Bruns, IAM, Karlsruhe Institute of Technology, Germany 11:45 Surface analytical characterization of high voltage spinel materials for Li-ion batteries Raheleh Azmi, IAM, Karlsruhe Institute of Technology, Germany 12:30 Lunch Break with Poster Session 13:45 Improvement of the XPS analysis considering **REELS** data for the identification of background features Manuel Monecke, Technical University Chemnitz, Germany 14:30 Microanalysis (and Surface Analysis) Jürgen Simon, Thermo Fisher Scientific, Germany 15:15 Coffee Break with Poster Session

16:00 Flash presentations Participants

End

17:00



Friday, June 24th

09:00	Avantage training: capabilities & applications (K-Alpha demo) Richard White, Tim Nunney, Michael Bruns and Surface Analysis Group
10:30	Coffee Break
11:00	Avantage training: capabilities & applications (K-Alpha demo) Richard White, Tim Nunney, Michael Bruns and Surface Analysis Group

Contributions

Participants are invited to present either 5-10 min. oral contributions during the flash presentation sessions or posters during coffee breaks with topics related to XPS in Materials Sciences.

Please provide a title together with your registration.

As there is only limited space for both types of contributions, the acceptation will be on a first come – first serve – base in terms of registration.

Contact:

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Organization:

Michael Bruns Karlsruhe Nano Micro Facility (KNMF)



Karlsruhe Institute of Technology (KIT) Eggenstein-Leopoldshafen, Germany





Venue

Karlsruhe Institute of Technology (KIT, Campus North) Hermann-von-Helmholtz-Platz 1 76344 Eggenstein-Leopoldshafen, Germany

Workshop: INT Lecture Hall, Building 640 K-Alpha Demo: IAM-ESS Building 321, 2nd floor Avantage Training: IAM-ESS Building 441/1

Hotel Recommendation:

Hotel availability is running out fast, so we encourage you to book soon:

Schröcker Tor Mannheimer Str. 1, 76344 Eggenstein-Leopoldshafen www.hotel-schroecker-tor.de +49 (0)7247 207490

Zum Goldenen Anker Hauptstraße 18-20, 76344 Eggenstein-Leopoldshafen www.hotel-anker-eggenstein.de +49 (0)721-706029

Gasthaus zur Krone Marktplatz 6, 76356 Weingarten www.krone-weingarten.de +49 (0)7244-947 380 Romantik Hotel Walk'sches Haus Marktplatz 7, 76356 Weingarten www.walksches-haus.de +49 (0)7244-7037-0

Brauhaus Wallhall Kübelmarkt 8, 76646 Bruchsal www.brauhaus-wallhall-bruchsal.de +49 (0)7251 7213 0

Hotel Ritter Au in den Buchen 73, 76646 Bruchsal-Büchenau www.ritterbruchsal.de +49 (0)7257 88-0

Registration:

The XPS workshop is free of charge, but space is limited. So, register today!

Please register online at **thermofisher.com/xps-workshop** until June 15th, 2016

